Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/640,851	BECHTEL ET AL.
Examiner	Art Unit
Thanh Y Luu	2878

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SEARCHED				
Class	Subclass	Date	Examiner	
250	205, 208.1, 214AL, 239	oylos	WL	
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INTERFERENCE SEARCHED				
Class	Subclass	Date		Examiner
Same as	above	04/0	15	JXC
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
		
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